## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10731730	SONI ET AL.
Examiner	Art Unit
Flores, Leon	2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	355	2/15/2007	LF	
370	206, 338	2/15/2007	LF	

SEARCH NOTES			
Search Notes	Date	Examiner	
Consulted with SPE David Payne in regards to the patentability of claim 1	2/20/2007	LF	
Search in NPL (IEEE)	2/15/2007	LF	
Checked for possible Double Patenting.	2/15/2007	LF	
Consulted with SPE David Payne in regards to the amendments.	9/7/2007	LF	
Consulted with SPE David Payne in regards to the amendments.	12/11/2007	LF	
Consulted with SPE Shuwang Liu in regards to the RCE.	2/8/2008	LF	
Consulted with SPE David Payne in regards to the RCE.	2/21/2008	LF	
Consulted with SPE David Payne in regards to the amendments.	10/10/2008	LF	
Consulted with SPE Shuwang Liu in regards to the amendment.	6/2/2009	LF	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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